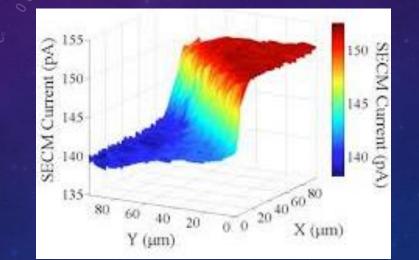


SCANNING ELECTROCHEMICAL MICROSCOPY



PRESENTED BY:

NOBUHLE NDEBELE

BACKGROUND

- Introduced by Bard and Engstorm simultaneously in the 1980s
- Electroanalytical scanning technique
- Quantitative technique
- Analyses the activity, morphology and topography of interfaces
- Monitors electric current flowing through the tip of a small electrode when scanned across a substrate
- The response depends on:
 - ✓ surface topography and
 - ✓ electrochemical activity



APPLICATIONS

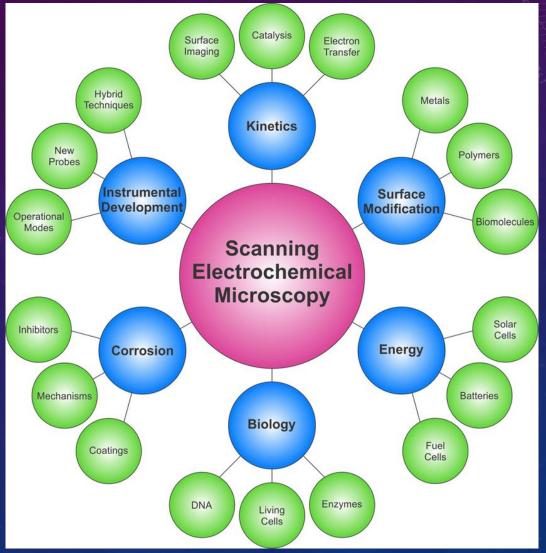
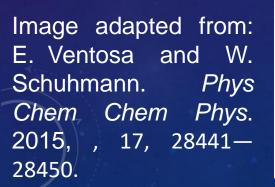


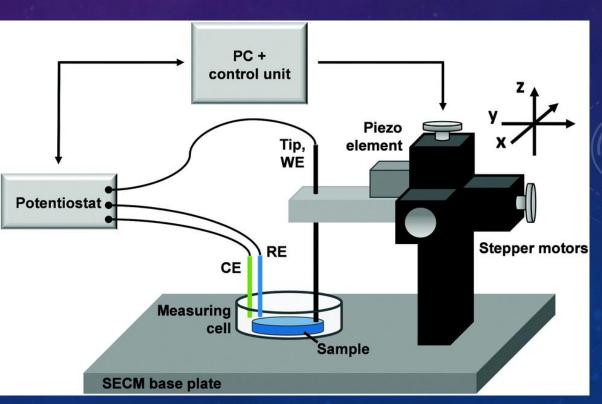
Image adapted from: Polcari. D, Dauphin-Ducharme. P, Mauzeroll. J. Chem rev. 2016. 116, 13234–13278



COMPONENTS

- Bipotentiostat
- 3D Positioning system
- SECM tip (small scale probe)
- Computer





ADDITIONAL COMPONENTS

- Optical microscope
- Fluorescence detection system
- Constant distance unit



PROBE

- Ultramicroelectrode (UME) < 25 μm
- Measurements depend on the dimensions of the probe (micrometer to nanometer)
 - ✓ fast steady-state response
 - ✓ Low electrical potential difference
- Probe selection depends on process under investigation
 - ✓ Amperometry
 - ✓ Potentiometry



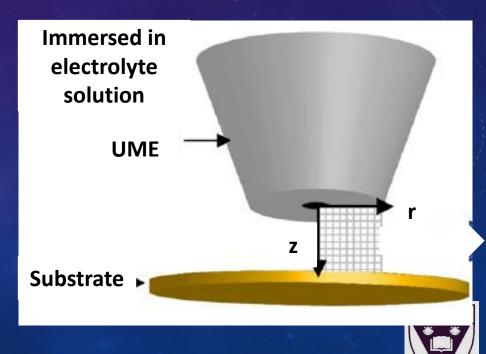
PROBES

- Amperometric probes
 ✓ 99%
 ✓ Highly robust
 ✓ Ease in probe positioning
 ✓ Fast response times (ms-ns)
 ✓ Low selectivity
- Potentiometric probes
 ✓ 1%
 ✓ Small lifetime
 ✓ Highly sensitive
 ✓ Slow response time (ms-s)
 ✓



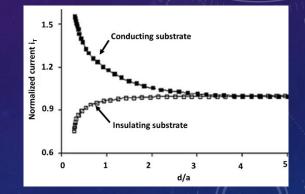
MODES OF OPERATION

- Tip generation/ tip collection mode
- Feedback potentiometric mode
- Redox competition mode
- Direct mode



FEEDBACK MODE PRINCIPLE

- Measures changes in tip current as the UME approaches the substrate in the presence of Fe²⁺/Fe³⁺ redox mediators
- Potential is applied
 - ✓ Oxidation: Fe²⁺/Fe³⁺
 - ✓ Rate: Diffusion of Fe^{2+} to the UME tip surface

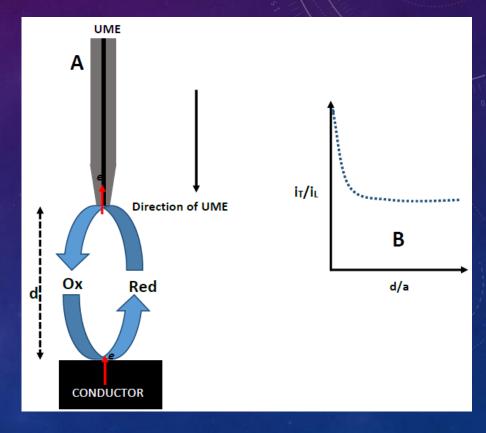


- Tip close to conducting surface: Fe³⁺ diffuses to the substrate (reduced)
 Increase in Fe²⁺ generation at the tip = increase in tip current
- Tip close to insulating surface: Fe³⁺ diffusion is hindered
 Decrease in Fe²⁺ at the tip = decrease in tip current



POSITIVE FEEDBACK

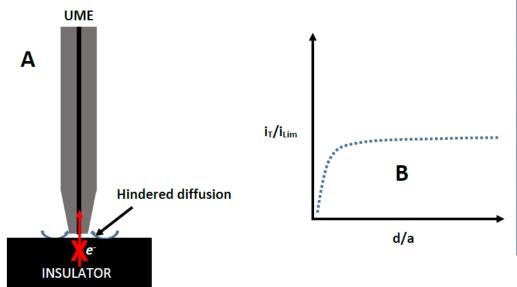
- Positive feedback
 - UME approaches conductive surface
- Large tip-substrate distance
 ✓ Tip current: mass transfer
 ✓ Current observed: limiting current
- Reduced tip-substrate distance
 ✓ Faradaic current increase
 ✓ Increase in tip currents





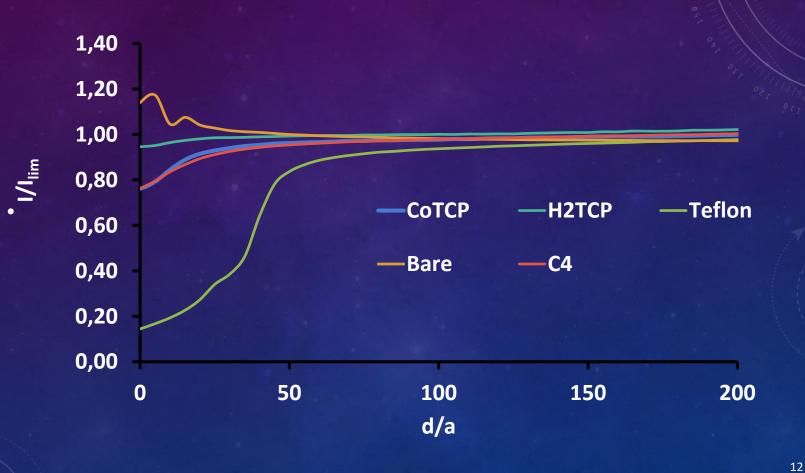
NEGATIVE FEEDBACK

- Negative feed back
 - ✓ UME approaches non-conductive surface
 - Diffusion of the redox species to the UME tip is hindered
 - ✓ Current decreases
 - ✓ Decrease in tip current.

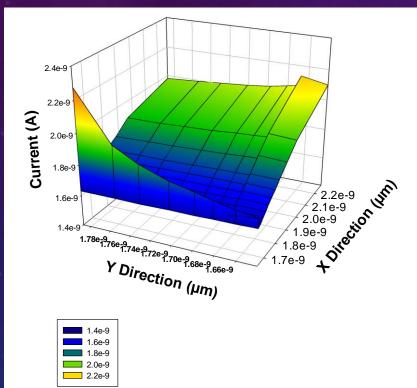


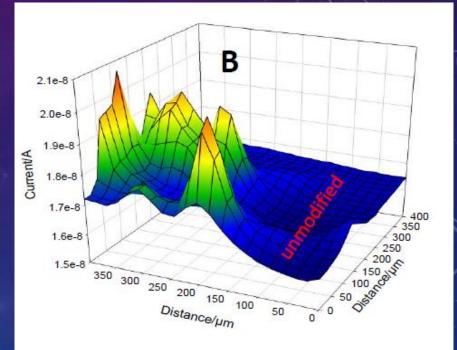


ANALYSIS



ANALYSIS







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